

Search Notes

Application/Control No.

10/057,576

Examiner

Hong Cho

Applicant(s)/Patent under
Reexamination

BONNEY ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	240, 241.1, 252	5/8/2006	HC
709	224	5/8/2006	HC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulte Chau Nguyen for search help	5/8/2006	HC